


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590994	<b>Applicant(s)/Patent Under Reexamination</b>  NAKANE ET AL.
	<b>Examiner</b>  Thien M. Le	<b>Art Unit</b>  2887

### SEARCHED

Class	Subclass	Date	Examiner
235	492	2/25/2010	MY
340	502, 505, 5.6, 5.64, 5.65, 10.51	2/25/2010	MY
updated	same as above	9/26/2010	LTM

### SEARCH NOTES

Search Notes	Date	Examiner
see seach history	2/25/2010	MY
reviewed related European application 05730561.7	2/25/2010	MY
updated	9/26/2010	LTM

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
235	492	9/26/2010	LTM
340	502	9/26/2010	LTM

/M. Y./  
Examiner,Art Unit 2887